

SEMITOP[®]E2 Solder

3-phase Converter-Inverter-Brake (CIB)

Engineering Sample SK35DGDL12T7ETE2s

Target Data

Features*

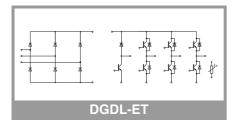
- Optimized design for superior thermal performance
- Low inductive design
- Solder contact technology
- 1200V Generation 7 IGBT (T7)Robust and soft switching CAL4F
- diode technology
- PEP rectifier diode technology for enhanced power and environmental robustness
- Integrated NTC temperature sensor
- UL recognized file no. E 63 532

Typical Applications

- Motor drives
- Air conditioning
- Auxiliary Inverters

Remarks

Absolute	Maximum Ratings	3		
Symbol	Conditions		Values	Unit
Inverter -	IGBT			
V _{CES}	T _i = 25 °C		1200	V
lc	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	51	Α
-	$T_j = 175 \text{ °C}$	T _s = 70 °C	41	Α
Ic	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	61	Α
-	T _j = 175 °C	T _s = 70 °C	50	Α
I _{Cnom}			35	Α
I _{CRM}			70	Α
V _{GES}			-20 20	V
t _{psc}	$V_{CC} = 800 V$ $V_{GE} \le 15 V$ $V_{CES} \le 1200 V$	T _j = 175 °C	7	μs
Tj		•	-40 175	°C
Chopper	- IGBT			
V _{CES}	T _i = 25 °C		1200	V
lc	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	51	Α
	T _j = 175 °C	T _s = 70 °C	41	А
lc	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	61	А
	T _j = 175 °C	T _s = 70 °C	50	Α
I _{Cnom}		1	35	А
I _{CRM}			70	Α
V _{GES}			-20 20	V
t _{psc}	$V_{CC} = 800 V$ $V_{GE} \le 15 V$ $V_{CES} \le 1200 V$	T _j = 175 °C	7	μs
Tj			-40 175	°C
Inverse -	Diode			•
V _{RRM}	T _j = 25 °C		1200	V
I _F	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	41	А
	T _j = 175 °C	T _s = 70 °C	33	Α
I _F	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	49	Α
	T _j = 175 °C	T _s = 70 °C	39	Α
I _{FRM}		1	70	Α
I _{FSM}	t _p = 10 ms, sin 180°	°, T _j = 150 °C	170	Α
Tj			-40 175	°C
Freewhee	eling - Diode		•	
V _{RRM}	T _j = 25 °C		1200	V
IF	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	15	Α
	$T_j = 175 \ ^\circ C$	T _s = 70 °C	12	A
l _F	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	16	Α
	$T_j = 175 \text{ °C}$	T _s = 70 °C	13	Α
I _{FRM}		1	20	Α
I _{FSM}	t _p = 10 ms, sin 180°	°, T _i = 150 °C	36	Α
Tj	r -	,	-40 175	°C





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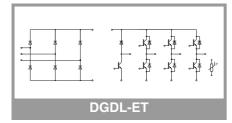
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- robustnessIntegrated NTC temperature sensor
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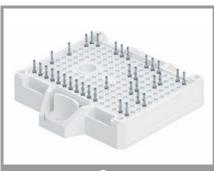
Typical Applications

- Motor drives
- Air conditioning
- Auxiliary Inverters

Remarks

Absolute	Maximum Ratings	5				
Symbol	Conditions			Values		Unit
Rectifier -	Diode					
V _{RRM}	T _i = 25 °C			1600		V
l _F	λ _{paste} =0.8 W/(mK)	T _s = 25 °C		61		Α
	T _j = 175 °C	T _s = 70 °C		47		Α
l _F	λ _{paste} =2.5 W/(mK)	T _s = 25 °C		72		Α
	T _j = 175 °C	T _s = 70 °C		57		Α
I _{FSM}	t _p = 10 ms	T _j = 25 °C		370		Α
	sin 180°	T _j = 150 °C		270		Α
i²t	$t_p = 10 \text{ ms}$	T _j = 25 °C		685		A ² s
	sin 180°	T _j = 150 °C		365		A ² s
Tj				-40 175		°C
Module						
I _{t(RMS)}	, $\Delta T_{terminal}$ at PCB jet	oint = 30 K, per pin		30		Α
T _{stg}	module without TIM	1		-40 125		°C
V _{isol}	AC, sinusoidal, 1 m	in		2500		V
Characte	riation					
Characte	1	I				I
Symbol	Conditions		min.	typ.	max.	Unit
Inverter -	-					
V _{CE(sat)}	I _C = 35 A	T _j = 25 °C		1.60	1.75	V
	V _{GE} = 15 V chiplevel	T _j = 150 °C		1.82	1.96	V
	cripievei	T _j = 175 °C		1.86	2.00	V
V _{CE0}		$T_j = 25 \ ^{\circ}C$		0.90	1.00	V
	chiplevel	T _j = 150 °C		0.75	0.83	V
		T _j = 175 °C		0.72	0.80	V
r _{CE}	V _{GE} = 15 V	$T_j = 25 \ ^{\circ}C$		20	21	mΩ
	chiplevel	T _j = 150 °C		31	32	mΩ
		T _j = 175 °C	F 4 F	33	34	mΩ
V _{GE(th)}	$V_{GE} = V_{CE}, I_C = 0.75$		5.15	5.8	6.45	V
	$V_{GE} = 0 V, V_{CE} = 12$	f = 1 MHz		0.0	1	mA mE
C _{ies}	V _{CE} = 25 V			6.6		nF
Coes	V _{GE} = 0 V	f = 1 MHz f = 1 MHz		0.0853		nF
C _{res}	V _{GE} = -15V+15V			0.024		nF
Q _G	$V_{GE} = -15V+15V$ $T_i = 25 \text{ °C}$			487		nC
R _{Gint}		T _j = 25 °C		0 43		Ω
t _{d(on)}	$V_{\rm CC} = 600 \rm V$	$T_{i} = 150 \text{ °C}$		45		ns
	$I_{C} = 35 \text{ A}$ R _{G on} = 5.6 Ω	$T_{i} = 175 \text{ °C}$		45		ns
+	$R_{G \text{ off}} = 5.6 \Omega$	$T_{i} = 25 ^{\circ}C$		30		ns
t _r	V _{GE} = +15/-15 V	$T_j = 25 \text{ C}$ $T_i = 150 \text{ °C}$		35		ns
		T _j = 130 °C T _i = 175 °C		35		ns
Eon	_ (T _j = 150 °C) di/dt _{on} = 1160 A/μs			2.51		ns mJ
∟on	$di/dt_{off} = 620 \text{ A/}\mu\text{s}$	$T_{j} = 25 \text{ C}$ $T_{i} = 150 \text{ °C}$		3.52		
	$dv/dt = 4600 V/\mu s$	T _j = 130 °C T _i = 175 °C				mJ
	-	ij=175 C		3.96		mJ





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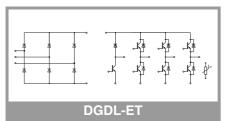
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- Optimized design for superior thermal performance
- Low inductive design
- Solder contact technology
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- UL recognized file no. E 63 532

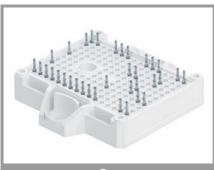
Typical Applications

- Motor drives
- Air conditioning
- Auxiliary Inverters

Remarks



Characte	eristics					
Symbol	Conditions		min.	typ.	max.	Unit
Inverter -	IGBT					
t _{d(off)}	V _{CC} = 600 V	T _i = 25 °C	1	183		ns
- (-)	$I_{\rm C} = 35 \rm{A}$	T _i = 150 °C		254		ns
	$R_{G \text{ on}} = 5.6 \Omega$	T _i = 175 °C	-	274		ns
t _f	$R_{G off} = 5.6 \Omega$	T _i = 25 °C		62		ns
	V _{GE} = +15/-15 V	T _i = 150 °C		95		ns
	(T _i = 150 °C)	T _i = 175 °C		102		ns
E _{off}	$di/dt_{on} = 1160 \text{ A}/\mu\text{s}$			2.83		mJ
011	di/dt _{off} = 620 A/µs	T _i = 150 °C		3.74		mJ
	dv/dt = 4600 V/µs	T _i = 175 °C		4.29		mJ
R _{th(j-s)}	per IGBT, λ _{paste} =0.8			1.17		K/W
R _{th(j-s)}	per IGBT, $\lambda_{\text{paste}}=2.8$			0.85		K/W
		5 W /(IIII()		0.00		10.0
Chopper	1	T 05 °C	1	1.60	1 75	L V
V _{CE(sat)}	$I_{\rm C} = 35 \rm{A}$	$T_j = 25 \degree C$		1.60	1.75	V
	V _{GE} = 15 V chiplevel	T _j = 150 °C		1.82	1.96	V
		T _j = 175 °C		1.86	2.00	V
V _{CE0}		$T_j = 25 \ ^\circ C$		0.90	1.00	V
	chiplevel	T _j = 150 °C		0.75	0.83	V
		T _j = 175 °C		0.72	0.80	V
r _{CE}	V _{GE} = 15 V	T _j = 25 °C		20	21	mΩ
	chiplevel	T _j = 150 °C		31	32	mΩ
		T _j = 175 °C		33	34	mΩ
V _{GE(th)}	$V_{GE} = V_{CE}, I_C = 0.75$		5.15	5.8	6.45	V
I _{CES}	$V_{GE} = 0 V, V_{CE} = 12$				1	mA
Cies	V _{CE} = 25 V	f = 1 MHz		6.6		nF
C _{oes}	$V_{GE} = 20 V$	f = 1 MHz		0.0853		nF
C _{res}	~	f = 1 MHz		0.024		nF
Q _G	V _{GE} = -15V+15V			487		nC
R _{Gint}	T _j = 25 °C			0		Ω
t _{d(on)}		T _j = 25 °C		43		ns
		T _j = 150 °C		45		ns
		T _j = 175 °C		46		ns
t _r		T _j = 25 °C		30		ns
		T _j = 150 °C		35		ns
	$V_{CC} = 600 V$	T _j = 175 °C		37		ns
Eon	$I_{\rm C} = 35 \rm{A}$	T _j = 25 °C		2.51		mJ
	$R_{G on} = 5.6 \Omega$ $R_{G off} = 5.6 \Omega$	T _i = 150 °C		3.52		mJ
	$V_{GE} = +15/-15 V$	T _j = 175 °C		3.96		mJ
t _{d(off)}		T _i = 25 °C		183		ns
. ,	$(T_j = 150 \ ^{\circ}C)$	T _i = 150 °C		254		ns
	di/dt _{on} = 1160 A/μs di/dt _{off} = 620 A/μs	T _j = 175 °C		274		ns
t _f	$dv/dt = 4600 V/\mu s$	T _i = 25 °C		62		ns
		T _i = 150 °C		95		ns
	-1	T _j = 175 °C		102		ns
E _{off}	-	$T_j = 25 \text{ °C}$		2.83		mJ
-011	_	$T_{j} = 150 \text{ °C}$		3.74		mJ
	-1	T _j = 175 °C		4.29		mJ
R _{th(j-s)}	per IGBT, λ _{paste} =0.8	-		1.17		K/W
• •tn(j-s)	per IGBT, $\lambda_{paste}=0.0$			0.85		K/W



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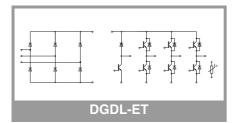
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Typical Applications

- Motor drives
- Air conditioning
- Auxiliary Inverters

Remarks

Characte	ristics					
Symbol	Conditions		min.	typ.	max.	Unit
Inverse -	Diode					
$V_F = V_{EC}$	I _F = 35 A	T _i = 25 °C	1	2.30	2.62	V
		T _i = 150 °C		2.29	2.62	V
	chiplevel	T _j = 175 °C		2.14	2.46	V
V _{F0}		T _j = 25 °C		1.30	1.50	V
-	chiplevel	T _i = 150 °C		0.90	1.10	V
	_	T _j = 175 °C		0.82	0.98	V
r _F		T _i = 25 °C		29	32	mΩ
	chiplevel	T _i = 150 °C		40	43	mΩ
	_	T _j = 175 °C		38	42	mΩ
I _{RRM}		T _j = 25 °C		25		Α
		T _i = 150 °C		31		Α
		T _j = 175 °C		37		Α
Q _{rr}	_ V _{CC} = 600 V I _F = 35 A	T _i = 25 °C	_	2.15		μC
	$V_{GE} = -15 V$	T _i = 150 °C	_	4.85		μC
	(T _i = 150 °C)	T; = 175 °C	_	5.48		μC
E _{rr}	di/dt _{off} = 1030 A/µs	T _i = 25 °C		1.46		mJ
		T _i = 150 °C	_	2.39		mJ
	_	T _i = 175 °C		3.65		mJ
R _{th(j-s)}	per Diode, $\lambda_{\text{paste}}=0$	1 -		1.34		K/W
R _{th(j-s)}	per Diode, $\lambda_{\text{paste}}=2$.		_	1.01		K/W
	ling - Diode					
$V_F = V_{EC}$	I _F = 10 A	T _i = 25 °C		2.59	2.94	V
		T _i = 150 °C	_	2.71	3.08	V
	chiplevel	T _i = 175 °C	_	2.53	2.89	V
V _{F0}		T _i = 25 °C	_	1.30	1.50	V
	chiplevel	T _i = 150 °C	_	0.90	1.10	V
		T _i = 175 °C	_	0.82	0.98	V
r _F		T _i = 25 °C	_	129	144	mΩ
	chiplevel	T _i = 150 °C	_	181	198	mΩ
		T _i = 175 °C	_	171	191	mΩ
I _{RRM}		T _i = 25 °C		8		Α
	-	T _i = 150 °C	_	14		Α
		T _i = 175 °C		16		Α
Q _{rr}	V _{CC} = 600 V I _F = 10 A	T _i = 25 °C		0.58		μC
	$V_{GE} = -15 V$	T _i = 150 °C		2.01		μC
	(T _j = 150 °C)	T _i = 175 °C		2.37		μC
Err	di/dt _{off} = 790 A/μs	T _i = 25 °C		0.36		mJ
	-	T _i = 150 °C		0.91		mJ
		T _i = 175 °C		1.16		mJ
R _{th(j-s)}	per Diode, $\lambda_{\text{paste}}=0$.			2.64		K/W
R _{th(j-s)}	per Diode, $\lambda_{\text{paste}}=2$.		1	2.24		K/W





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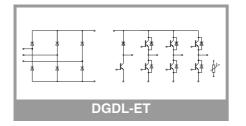
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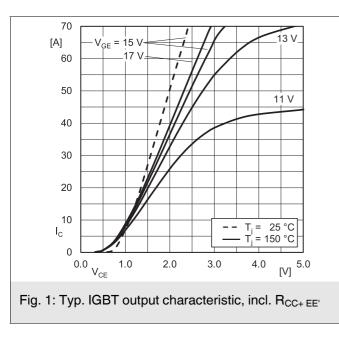
Typical Applications

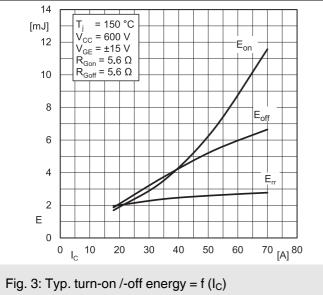
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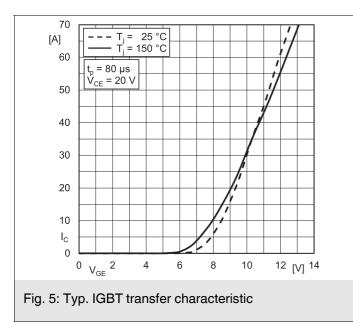
Remarks

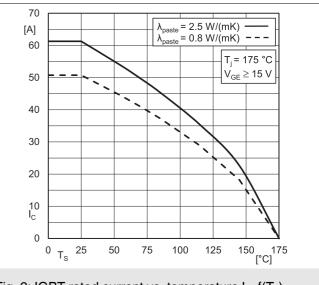
Characte	ristics					
Symbol	Conditions		min.	typ.	max.	Unit
Rectifier -	Diode					
V _F		T _j = 25 °C		1.10	1.39	V
	I _F = 35 A chiplevel	T _j = 150 °C		1.04	1.33	V
		T _j = 175 °C		1.04	1.34	V
V _{F0}		T _j = 25 °C		0.89	1.09	V
	chiplevel	T _j = 150 °C		0.73	0.92	V
	_	T _j = 175 °C		0.69	0.88	V
r _F	chiplevel	T _j = 25 °C		6.2	8.5	mΩ
		T _j = 150 °C		8.8	12	mΩ
		T _j = 175 °C		10.0	13	mΩ
I _R	T _j = 150 °C, V _{RRM}				2	mA
R _{th(j-s)}	per Diode, λ_{paste} =0.8 W/(mK)			1.48		K/W
R _{th(j-s)}	per Diode, λ _{paste} =2.5 W/(mK)			1.14		K/W
Module						
Ms	to heatsink		1.6		2.3	Nm
w				35		g
L _{CE}	1			30		nH
Temperat	ure Sensor					
R ₁₀₀	T _c =100°C (R ₂₅ =5	kΩ)		493 ± 5%		Ω
B _{25/85}	-	₈₅ *(1/T-1/298)], T[K]		3420		K













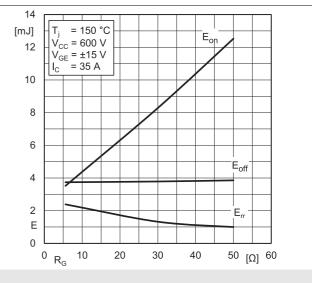


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

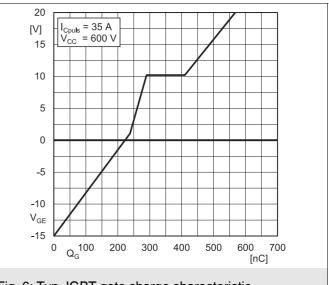
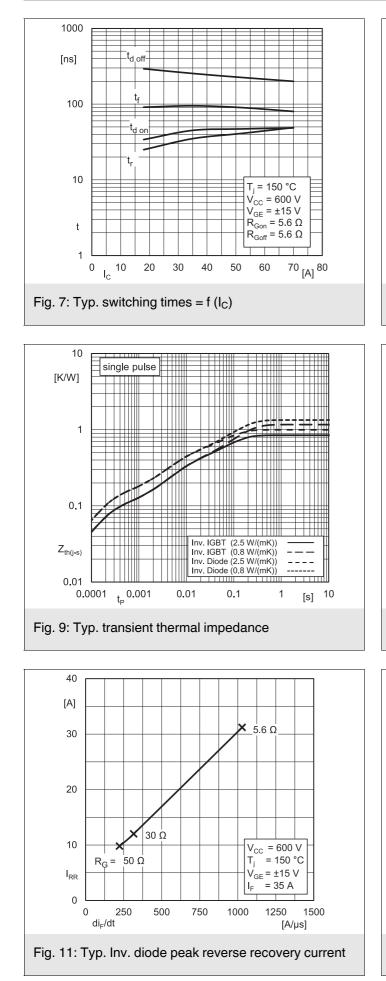
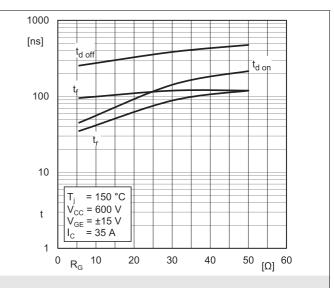
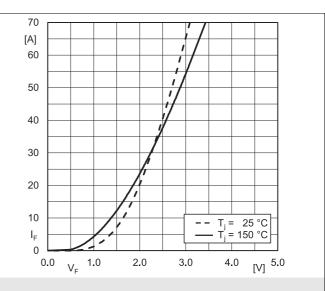


Fig. 6: Typ. IGBT gate charge characteristic

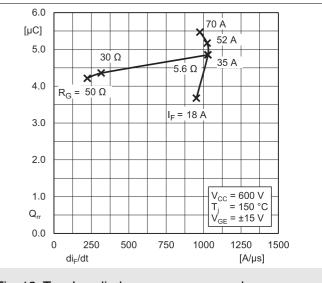


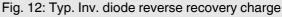


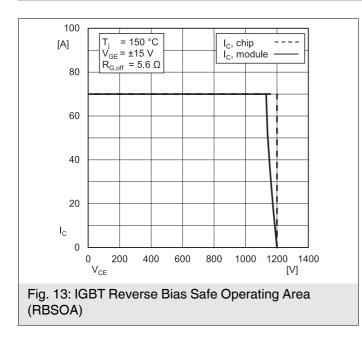


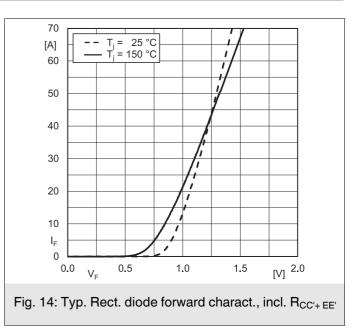


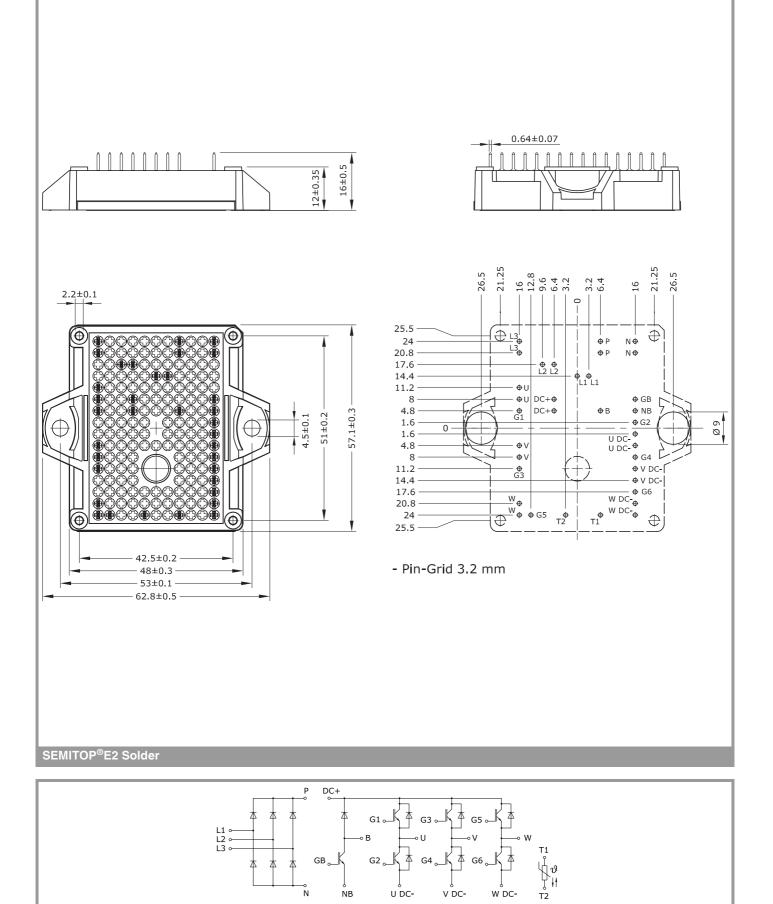














U DC-

V DC-

W DC-

NB

This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

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